



MEASUREMENT REPORT

FCC PART 74 Subpart H

FCC ID: DD4SLXD2J52

APPLICANT: Shure Incorporated

Application Type: Certification

Product: Digital Wireless Microphone Transmitter

Model No.: SLXD2 J52

Brand Name:  **SHURE**

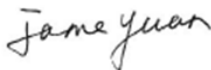
FCC Classification: Licensed LPAS Device (TLD)

FCC Rule Part(s): Part 74 Subpart H (Section 74.861)

Test Procedure(s): ANSI C63.26-2015, KDB 206256 D01v02
ETSI EN 300 422-1 V1.4.2 (2011-08)

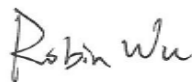
Test Date: October 21 ~ November 29, 2019

Reviewed By:



(Jame Yuan)

Approved By:



(Robin Wu)



The test results relate only to the samples tested.

The test results shown in the test report are traceable to the national/international standards through the calibration of the equipment and evaluated measurement uncertainty herein.

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Revision History

Report No.	Version	Description	Issue Date	Note
1910RSU040-U8	Rev. 01	Initial Report	12-01-2019	Valid

CONTENTS

Description	Page
§2.1033 General Information	5
1. INTRODUCTION	6
1.1. Scope	6
1.2. MRT Test Location	6
2. PRODUCT INFORMATION	7
2.1. Equipment Description	7
2.2. Product Specification Subjective to this Report	7
2.3. Working Frequencies for this report	7
2.4. Test Software	7
2.5. EMI Suppression Device(s) / Modifications	7
3. DESCRIPTION OF TEST	8
3.1. Evaluation Procedure	8
3.2. Radiated Measurement	8
4. TEST EQUIPMENT CALIBRATION DATE	10
5. MEASUREMENT UNCERTAINTY	12
6. TEST RESULT	13
6.1. Summary	13
6.2. RF Output Power Measurement	14
6.2.1. Test Limit	14
6.2.2. Test Procedure Used	14
6.2.3. Test Setting	14
6.2.4. Test Setup	14
6.2.5. Test Result	15
6.1. Frequency Tolerance Measurement	16
6.1.1. Test Limit	16
6.1.2. Test Procedure	16
6.1.3. Test Setting	16
6.1.4. Test Setup	17
6.1.5. Test Result	18
6.2. 99% Occupied Bandwidth Measurement	20
6.2.1. Test Limit	20
6.2.2. Test Procedure used	20
6.2.3. Test Setting	20

6.2.4. Test Setup.....	20
6.2.5. Test Result.....	21
6.3. Out-of-band Emission Mask Measurement	22
6.3.1. Test Limit	22
6.3.2. Test Procedure Used	22
6.3.3. Test Setting.....	22
6.3.4. Test Setup.....	23
6.3.5. Test Result.....	24
6.4. Necessary Bandwidth Measurement.....	27
6.4.1. Test Limit	27
6.4.2. Test Procedure Used	27
6.4.3. Test Setting.....	27
6.4.4. Test Setup.....	28
6.4.5. Test Result.....	29
6.5. Radiated Spurious Emissions Measurement.....	35
6.5.1. Test Limit	35
6.5.2. Test Procedure Used	35
6.5.3. Test Setting.....	35
6.5.4. Test Setup.....	36
6.5.5. Test Result.....	37
7. CONCLUSION.....	39
Appendix A – Test Setup Photograph.....	40
Appendix B – EUT Photograph	41

§2.1033 General Information

Applicant:	Shure Incorporated
Applicant Address:	5800 West Touhy Avenue, Niles, IL 60714-4608, USA
Manufacturer:	Shure Incorporated
Manufacturer Address:	5800 West Touhy Avenue, Niles, IL 60714-4608, USA
Test Site:	MRT Technology (Suzhou) Co., Ltd
Test Site Address:	D8 Building, No.2 Tian'edang Rd., Wuzhong Economic Development Zone, Suzhou, China
Test Device Serial No.:	N/A ☐ Production ☒ Pre-Production ☐ Engineering

Test Facility / Accreditations

Measurements were performed at MRT Laboratory located in Tian'edang Rd., Suzhou, China.

- MRT facility is a FCC accredited (MRT Designation No. CN1166) test facility with the site description report on file and has met all the requirements specified in ANSI C63.4-2014.
- MRT facility is an IC registered (MRT Reg. No. 11384A-1) test laboratory with the site description on file at Industry Canada.
- MRT facility is a VCCI registered (R-20025, G-20034, C-20020, T-20020) test laboratory with the site description on file at VCCI Council.
- MRT Lab is accredited to ISO 17025 by the American Association for Laboratory Accreditation (A2LA) under the American Association for Laboratory Accreditation Program (A2LA Cert. No. 3628.01) in EMC, Telecommunications, Radio and SAR testing.



1. INTRODUCTION

1.1. Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada and Certification and Engineering Bureau.

1.2. MRT Test Location

The map below shows the location of the MRT LABORATORY, its proximity to the Taihu Lake. These measurement tests were conducted at the MRT Technology (Suzhou) Co., Ltd. Facility located at D8 Building, No.2 Tian'edang Rd., Wuzhong Economic Development Zone, Suzhou, China. The measurement facility compliant with the test site requirements specified in ANSI C63.4-2014.



2. PRODUCT INFORMATION

2.1. Equipment Description

Product Name	Digital Wireless Microphone Transmitter
Model No.	SLXD2 J52
Power Type	Two AA batteries (3.0Vdc) or Rechargeable Li-ion Battery Pack
Working Voltage	1.9 ~ 4.2 Vdc
Operating Temperature	-18 ~ 50°C
Accessories	
Rechargeable Li-ion Battery	Model: SB903 Output: 3.6Vdc, 1200mAh, 4.32Wh

2.2. Product Specification Subjective to this Report

Frequency Range	558 ~ 602MHz
Declared Power Level	1mW & 10mW
Type of Modulation	4FSK
Channel Spacing	25kHz
Antenna Type	Dipole Antenna
Antenna Gain	0.1dBi

Note 1: For other features of this EUT, test report will be issued separately.

Note 2: Power level and operating frequency can be selected via EUT screen.

2.3. Working Frequencies for this report

Channel	Frequency
Low	558.000 MHz
...	...
Mid	580.000 MHz
...	...
High	602.000 MHz

2.4. Test Software

The test utility software used during testing was "IPOP", and the version was V4.1, all test commands were provided by the manufacturer.

2.5. EMI Suppression Device(s) / Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

3. DESCRIPTION OF TEST

3.1. Evaluation Procedure

The measurement procedures described in the American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services (ANSI C63.26-2015).

Deviation from measurement procedure.....None

3.2. Radiated Measurement

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. A turntable is used for radiated measurement. It is a continuously rotatable, remote controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm high PVC support structure is placed on top of the turntable.

For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies above 1GHz, linearly polarized double ridge horn antennas were used. For frequencies below 30MHz, a calibrated loop antenna was used. When exploratory measurements were necessary, they were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies and modes producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up for frequencies below 1GHz was placed on top of the 0.8 meter high, 1 x 1.5 meter table; and test set-up for frequencies 1-40GHz was placed on top of the 1.5 meter high, 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, if applicable, turntable azimuth, and receive antenna height was noted for each frequency found.

Final measurements were made in the semi-anechoic chamber using calibrated, linearly polarized broadband and horn antennas. The test setup was configured to the setup that produced the worst case emissions. The spectrum analyzer was set to investigate all frequencies required for testing to compare the highest radiated disturbances with respect to the specified limits. The turntable containing the EUT was rotated through 360 degrees and the height of the receive antenna was

varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, which produced the worst-case emissions.

According to 3dB Beam-Width of horn antenna, the horn antenna should be always directed to the EUT when rising height.

4. TEST EQUIPMENT CALIBRATION DATE

Conducted Emissions - SR2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
EMI Test Receiver	R&S	ESR3	MRTSUE06185	1 year	2020/04/15
Two-Line V-Network	R&S	ENV 216	MRTSUE06002	1 year	2020/06/13
Two-Line V-Network	R&S	ENV 216	MRTSUE06003	1 year	2020/06/13
Thermohygrometer	Testo	608-H1	MRTSUE06404	1 year	2020/08/08
Shielding Room	MIX-BEP	Chamber-SR2	MRTSUE06215	N/A	N/A

Radiated Emissions - AC1

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
EMI Test Receiver	R&S	ESR7	MRTSUE06001	1 year	2020/08/01
PXA Signal Analyzer	Keysight	9030B	MRTSUE06395	1 year	2020/09/03
Loop Antenna	Schwarzbeck	FMZB 1519	MRTSUE06025	1 year	2020/11/10
Bilog Period Antenna	Schwarzbeck	VULB 9168	MRTSUE06172	1 year	2020/03/31
Broad Band Horn Antenna	Schwarzbeck	BBHA 9120D	MRTSUE06023	1 year	2020/10/13
Broad Band Horn Antenna	Schwarzbeck	BBHA 9170	MRTSUE06024	1 year	2019/12/17
Microwave System Amplifier	Agilent	83017A	MRTSUE06076	1 year	2020/11/15
Preamplifier	Schwarzbeck	BBV 9721	MRTSUE06121	1 year	2020/06/11
Thermohygrometer	Testo	608-H1	MRTSUE06403	1 year	2020/08/08
Anechoic Chamber	TDK	Chamber-AC1	MRTSUE06212	1 year	2020/04/30

Radiated Emission - AC2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Spectrum Analyzer	Keysight	N9038A	MRTSUE06125	1 year	2020/08/01
Loop Antenna	Schwarzbeck	FMZB 1519	MRTSUE06025	1 year	2020/11/10
Bilog Period Antenna	Schwarzbeck	VULB 9162	MRTSUE06022	1 year	2020/10/13
Horn Antenna	Schwarzbeck	BBHA9120D	MRTSUE06171	1 year	2020/10/27
Broad Band Horn Antenna	Schwarzbeck	BBHA 9170	MRTSUE06024	1 year	2019/12/17
Broadband Coaxial Preamplifier	Schwarzbeck	BBV 9718	MRTSUE06176	1 year	2020/11/15
Preamplifier	Schwarzbeck	BBV 9721	MRTSUE06121	1 year	2020/06/11
Temperature/Humidity Meter	Minggao	ETH529	MRTSUE06170	1 year	2019/12/13
Anechoic Chamber	RIKEN	Chamber-AC2	MRTSUE06213	1 year	2020/04/30

Conducted Test Equipment - TR3

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
EXA Signal Analyzer	Agilent	N9020A	MRTSUE06106	1 year	2020/04/15
EXA Signal Analyzer	Keysight	N9010B	MRTSUE06452	1 year	2020/07/11
Signal Analyzer	R&S	FSV40	MRTSUE06218	1 year	2020/04/15
Power Meter	Agilent	U2021XA	MRTSUE06030	1 year	2020/11/18
USB wideband power sensor	Keysight	U2021XA	MRTSUE06446	1 year	2020/06/30
USB wideband power sensor	Keysight	U2021XA	MRTSUE06447	1 year	2020/06/30
Bluetooth Test Set	Anritsu	MT8852B-042	MRTSUE06389	1 year	2020/06/13
Audio Analyzer	Agilent	U8903B	MRTSUE06143	1 year	2020/06/13
Modulation Analyzer	HP	8901A	MRTSUE06098	1 year	2020/10/10
Wideband Radio Communication Tester	R&S	CMW 500	MRTSUE06243	1 year	2020/11/07
DC Power Supply	GWINSTEK	DPS-3303C	MRTSUE06064	N/A	N/A
Temperature & Humidity Chamber	BAOYT	BYH-150CL	MRTSUE06051	1 year	2020/11/07
Thermohygrometer	testo	608-H1	MRTSUE06401	1 year	2020/08/08

Software	Version	Function
EMI Software	V3	EMI Test Software

5. MEASUREMENT UNCERTAINTY

Where relevant, the following test uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k = 2$.

Conducted Emission Measurement - SR2	
The maximum measurement uncertainty is evaluated as:	
9kHz~150kHz: 3.84dB	
150kHz~30MHz: 3.46dB	
Radiated Emission Measurement - AC1	
The maximum measurement uncertainty is evaluated as:	
Horizontal:	30MHz~300MHz: 4.07dB
	300MHz~1GHz: 3.63dB
	1GHz~18GHz: 4.16dB
Vertical:	30MHz~300MHz: 4.18dB
	300MHz~1GHz: 3.60dB
	1GHz~18GHz: 4.76dB
Radiated Emission Measurement - AC2	
The maximum measurement uncertainty is evaluated as:	
Horizontal:	30MHz~300MHz: 3.75dB
	300MHz~1GHz: 3.53dB
	1GHz~18GHz: 4.28dB
Vertical:	30MHz~300MHz: 3.86dB
	300MHz~1GHz: 3.53dB
	1GHz~18GHz: 4.33dB

6. TEST RESULT

6.1. Summary

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
74.861(e)(1)(ii)	RF Output Power	$\leq 250\text{mW}$ Conducted	Conducted	Pass	Section 6.2
74.861(e)(4)	Frequency Stability	$\pm 0.005\%$		Pass	Section 6.3
74.861(e)(5)	Occupied Bandwidth	$< 200\text{kHz}$		Pass	Section 6.4
74.861(e)(6)	Emission Mask	The mean power of emissions shall be attenuated below the mean output power of the transmitter as below: (50% ~ 100%)*OBW $\geq 25\text{dB}$ (100% ~ 250%)*OBW $\geq 35\text{dB}$ More than 250%*OBW $\geq 43 + 10*\log(P)\text{dB}$		Pass	Section 6.5
74.861(e)(7)	Necessary Bandwidth	Refer to clause 6.6.1		N/A	Section 6.6
74.861(e)(7)	Radiated Spurious Emission	Refer to clause 6.7.1	Radiated	Pass	Section 6.7

Notes:

- 1) The analyzer plots shown in this section were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables and attenuators used as part of the system to connect the EUT to the analyzer at all frequencies of interest.
- 2) All modes of operation and data rates were investigated. For radiated emission test, every axis (X, Y, Z) was also verified. The test results shown in the following sections represent the worst emissions.
- 3) Besides RF Output Power & Necessary Bandwidth & Radiated Spurious Emission & Emission Mask perform two power levels, any others test item only perform max power level.
- 4) We selected DC voltage 3.6V as normal test voltage.

6.2. RF Output Power Measurement

6.2.1. Test Limit

The conducted power may not exceed 250mW in 470 ~ 608 and 614 ~ 698 MHz band.

6.2.2. Test Procedure Used

ANSI C63.26-2015 - Section 5.2.4.2

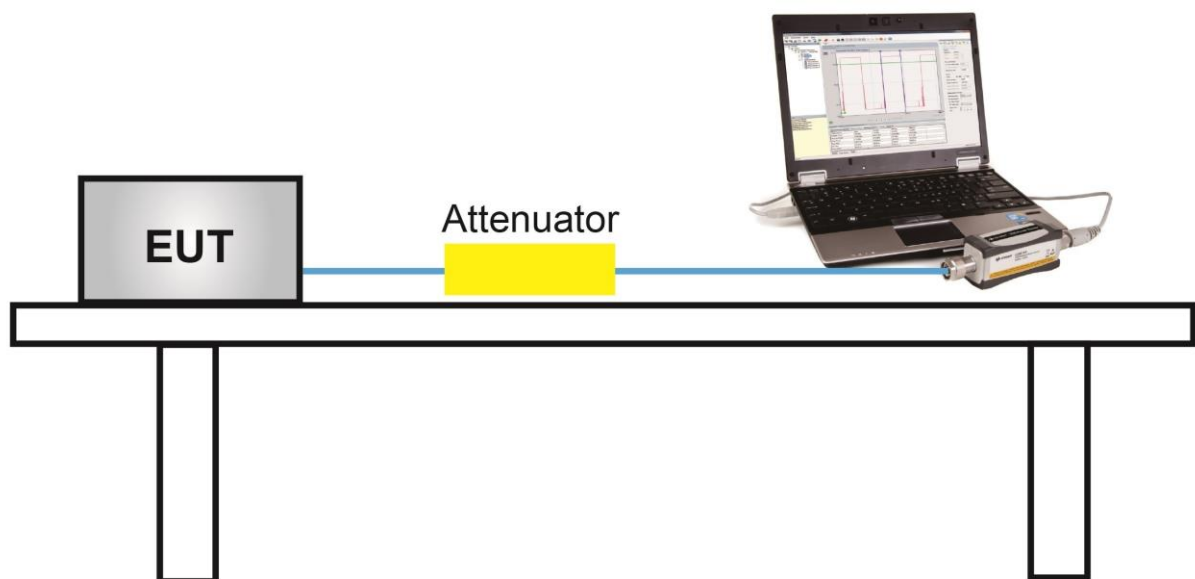
6.2.3. Test Setting

The output of the EUT was connected to an RF average power meter through fixed attenuation.

The EUT was set to transmit on the low, middle, and high frequencies in each power level.

Measure the average power of the transmitter. This EUT's duty cycle is 100%.

6.2.4. Test Setup



6.2.5. Test Result

Test Site	TR3	Temperature	25°C
Test Engineer	Andy Zhu	Relative Humidity	52%
Test Mode	J52 Band	Test Date	2019/10/25

Frequency (MHz)	Power Meter Level (dBm)	Conducted Power Limit (dBm)	Test Result
1mW			
558.000	-0.640	≤ 23.98	Pass
580.000	-1.100	≤ 23.98	Pass
602.000	-1.660	≤ 23.98	Pass
10mW			
558.000	10.180	≤ 23.98	Pass
580.000	9.970	≤ 23.98	Pass
602.000	10.060	≤ 23.98	Pass

Note: Limit (dBm) = $10 \cdot \log(250 \text{ mW}) = 23.98 \text{ dBm}$.

6.1. Frequency Tolerance Measurement

6.1.1. Test Limit

The frequency tolerance of the transmitter shall be 0.005 percent.

6.1.2. Test Procedure

ANSI C63.26 - Section 5.6.3

6.1.3. Test Setting

Frequency Stability Under Temperature Variations:

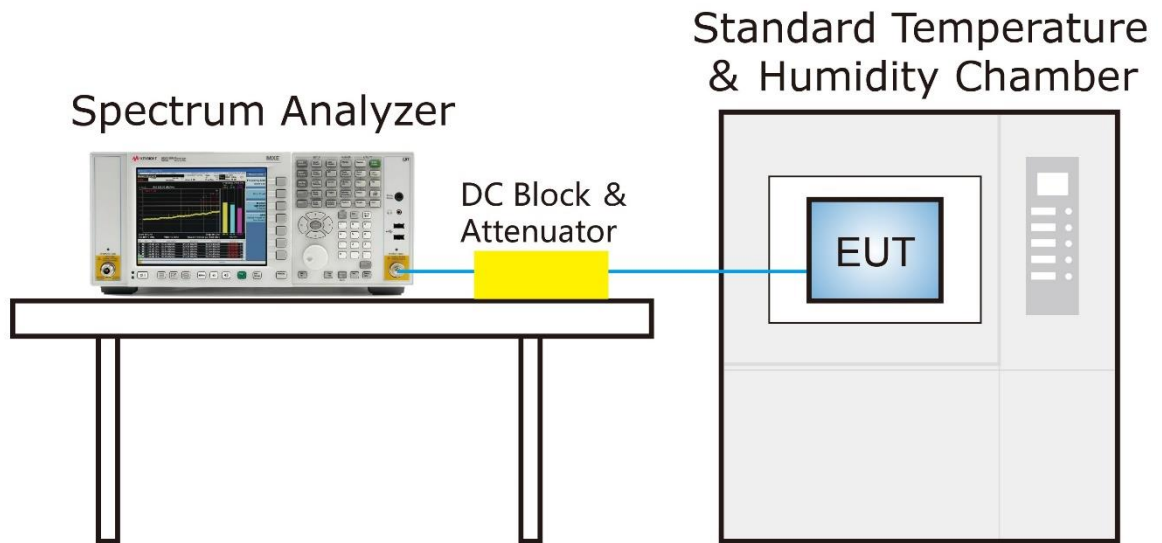
The equipment under test was connected to an external AC or DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 20°C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to highest. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C decreased per stage until the lowest temperature reached.

Frequency Stability Under Voltage Variations:

Set chamber temperature to 20°C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

Reduce the input voltage to specify extreme voltage variation ($\pm 15\%$) and endpoint (If a product is specified to operate over a range of input voltage then the -15% variation is applied to the lowermost voltage and the $+15\%$ is applied to the uppermost voltage), record the maximum frequency change.

6.1.4. Test Setup



6.1.5. Test Result

Test Site	TR3	Temperature	-20 ~ 50°C
Test Engineer	Andy Zhu	Relative Humidity	48 ~ 55%RH
Test Mode	J52 Band - 10mW	Test Date	2019/10/25

Voltage (%)	Power (V _{DC})	Temp (°C)	Nominal Frequency (MHz)	Measured Frequency (MHz)	Deviation (%)	Limit (%)	Result
100%	3.60	-20	558.000	558.000118	0.000021	-/+0.005	Pass
			580.000	579.999808	-0.000033	-/+0.005	Pass
			602.000	601.999807	-0.000032	-/+0.005	Pass
		-10	558.000	558.000114	0.000020	-/+0.005	Pass
			580.000	579.999889	-0.000019	-/+0.005	Pass
			602.000	601.999891	-0.000018	-/+0.005	Pass
		0	558.000	558.000134	0.000024	-/+0.005	Pass
			580.000	579.8999990	-0.000172	-/+0.005	Pass
			602.000	601.999994	-0.000001	-/+0.005	Pass
		+10	558.000	558.000093	0.000017	-/+0.005	Pass
			580.000	580.000081	0.000014	-/+0.005	Pass
			602.000	602.000092	0.000015	-/+0.005	Pass
		+20 (Ref)	558.000	557.999901	-0.000018	-/+0.005	Pass
			580.000	580.000181	0.000031	-/+0.005	Pass
			602.000	602.000189	0.000031	-/+0.005	Pass
		+30	558.000	557.999739	-0.000047	-/+0.005	Pass
			580.000	580.000216	0.000037	-/+0.005	Pass
			602.000	602.000228	0.000038	-/+0.005	Pass
		+40	558.000	557.999597	-0.000072	-/+0.005	Pass
			580.000	580.000310	0.000053	-/+0.005	Pass
			602.000	602.000324	0.000054	-/+0.005	Pass
		+50	558.000	557.999551	-0.000080	-/+0.005	Pass
			580.000	580.000359	0.000062	-/+0.005	Pass
			602.000	602.000372	0.000062	-/+0.005	Pass

Voltage (%)	Power (V _{DC})	Temp (°C)	Nominal Frequency (MHz)	Measured Frequency (MHz)	Deviation (%)	Limit (%)	Result
115%	4.14	+20	558.000	557.999760	-0.000043	-/+0.005	Pass
			580.000	580.000091	0.000016	-/+0.005	Pass
			602.000	602.000097	0.000016	-/+0.005	Pass
85%	3.06	+20	558.000	557.999771	-0.000041	-/+0.005	Pass
			580.000	580.000121	0.000021	-/+0.005	Pass
			602.000	602.000130	0.000022	-/+0.005	Pass

Note 1: Frequency Tolerance (%) = {[Measured Frequency (MHz) - Nominal Frequency (MHz)] / Nominal Frequency (MHz)} *10².

6.2. 99% Occupied Bandwidth Measurement

6.2.1. Test Limit

The operating bandwidth shall not exceed 200 kHz.

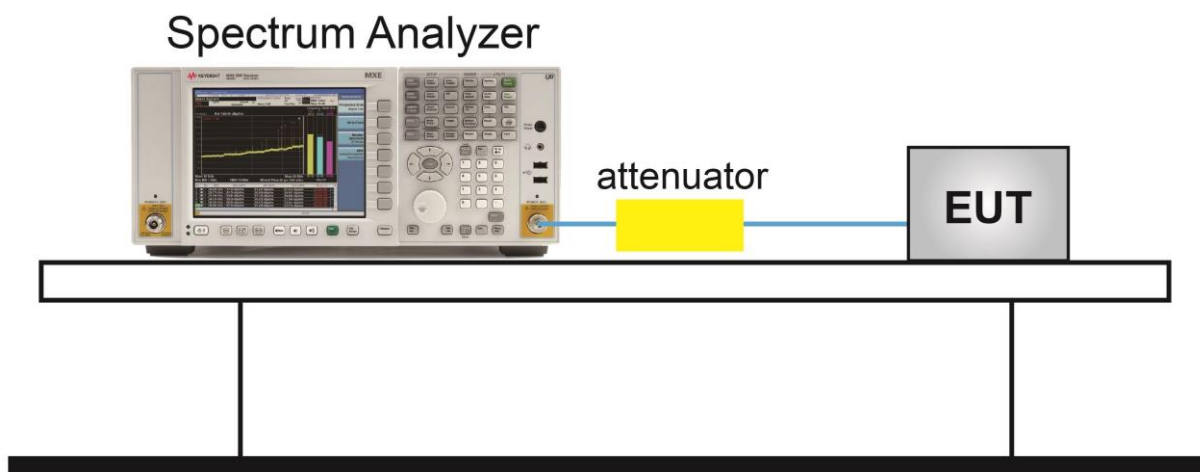
6.2.2. Test Procedure used

ANSI C63.26-2015 - Section 5.4.4

6.2.3. Test Setting

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 - 5% of the expected OBW
3. VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. Reported the measured 99% occupied bandwidth

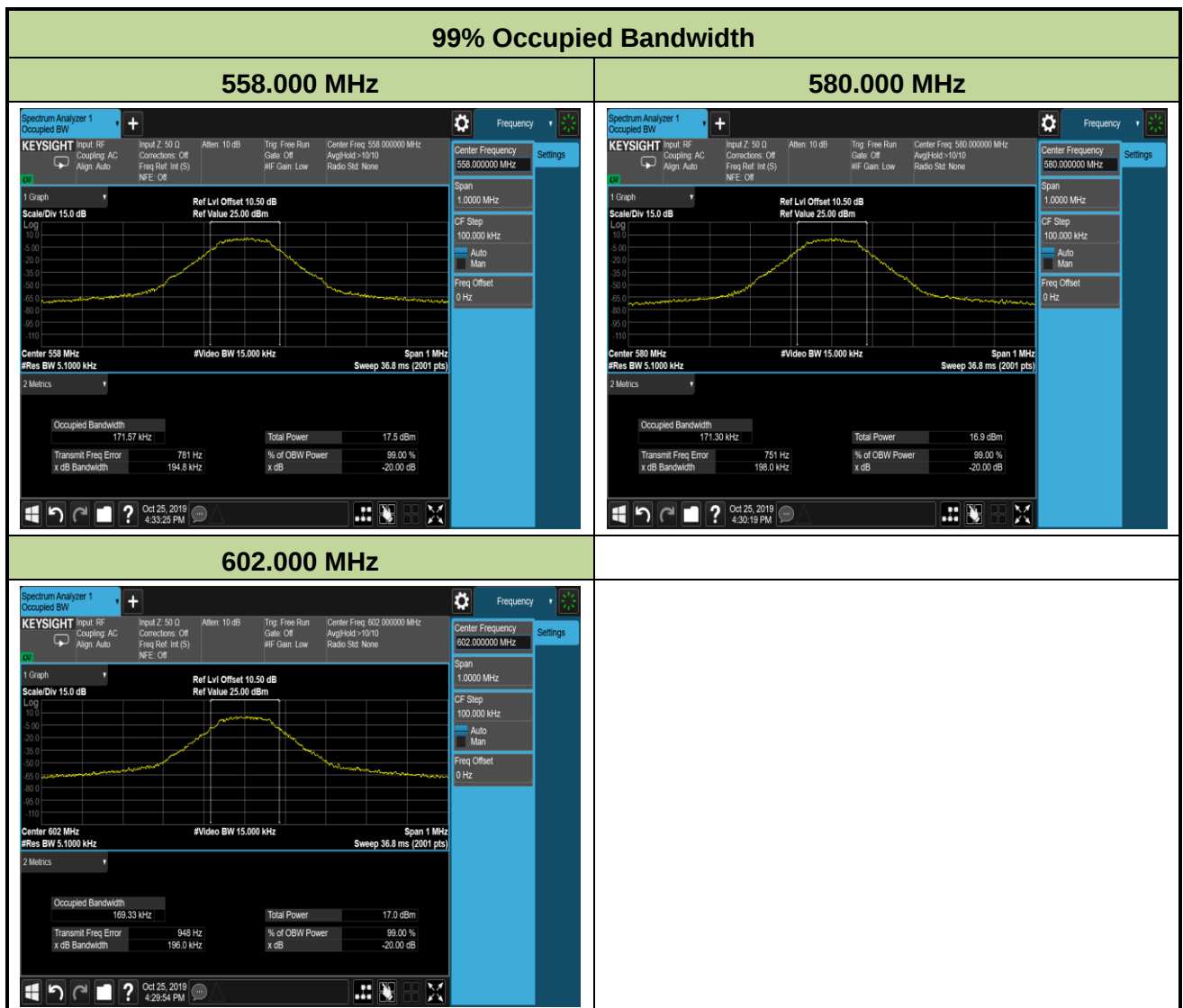
6.2.4. Test Setup



6.2.5. Test Result

Test Site	TR3	Temperature	25°C
Test Engineer	Andy Zhu	Relative Humidity	52%
Test Mode	J52 Band - 10mW	Test Date	2019/10/25

Frequency (MHz)	99% Bandwidth (kHz)	Limit (kHz)	Result
558.000	171.57	< 200	Pass
580.000	171.30	< 200	Pass
602.000	169.33	< 200	Pass



6.3. Out-of-band Emission Mask Measurement

6.3.1. Test Limit

The mean power of emissions shall be attenuated below the mean output power of the transmitter in accordance with the following schedule:

- (i) On any frequency removed from the operating frequency by more than 50 percent up to and including 100 percent of the authorized bandwidth: at least 25 dB;
- (ii) On any frequency removed from the operating frequency by more than 100 percent up to and including 250 percent of the authorized bandwidth: at least 35 dB;
- (iii) On any frequency removed from the operating frequency by more than 250 percent of the authorized bandwidth: at least $43 + 10 \log_{10}$ (mean output power in watts) dB.

6.3.2. Test Procedure Used

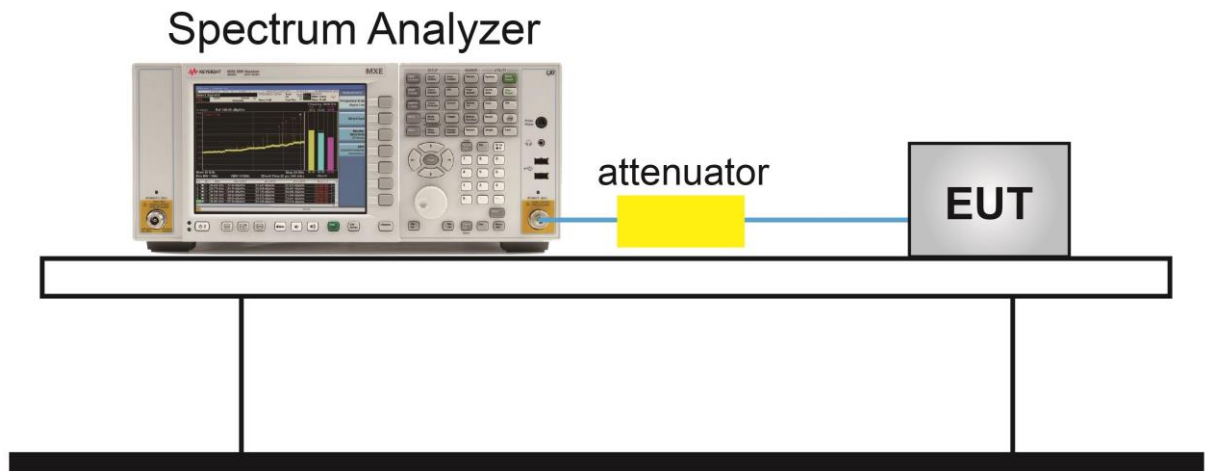
ANSI C63.26 - Section 5.7

6.3.3. Test Setting

Emission Mask

- a) The EUT was connected to a spectrum analyzer. The un-modulated carrier signal level was measured and recorded.
- b) The EUT was modulated with typical digital modulation.
- c) The spectrum analyzer center frequency was set to the EUT operating frequency; span was set to 2 MHz; resolution bandwidth was set to 1 MHz; video bandwidth set to 3 MHz; sweep time set to 3 s; after clear/write, max-hold was set; Marker 1 was set to Peak, then Marker 1 was set to reference value.
- d) The peak output power was recorded and used to set the reference level on the spectrum analyzer.
- e) The spectrum analyzer span was then set to 1.5 MHz; resolution bandwidth set to 2 kHz, video bandwidth set to 5 kHz, sweep time to Auto; trace set to Max Hold.

6.3.4. Test Setup



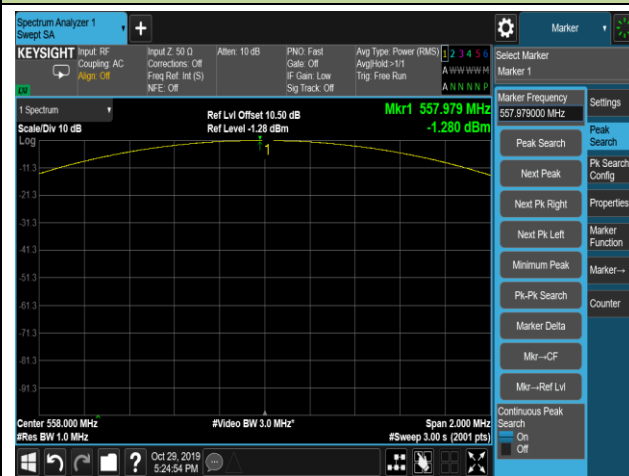
6.3.5. Test Result

Test Site	TR3	Temperature	25°C
Test Engineer	Andy Zhu	Relative Humidity	52%
Test Mode	J52 Band	Test Date	2019/10/29

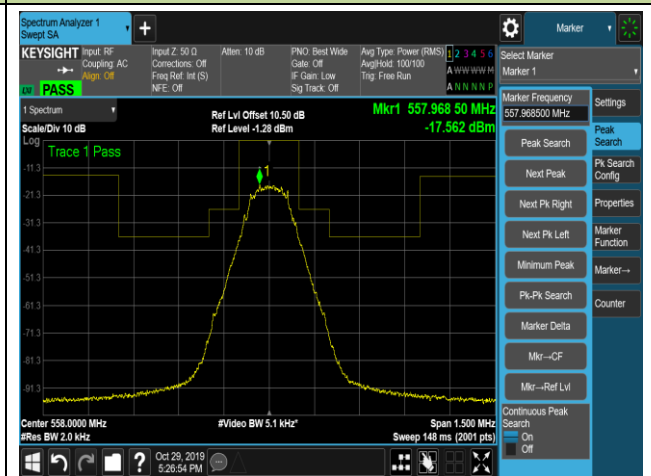
J52 58 Band 1mW - Emission Mask

Channel 558.000MHz

Reference Level

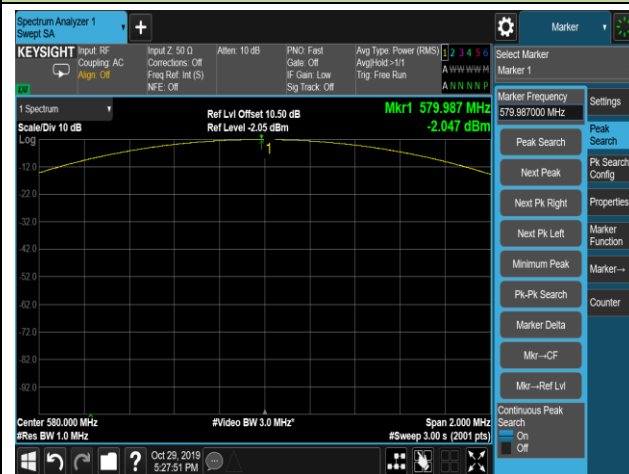


Emission Mask

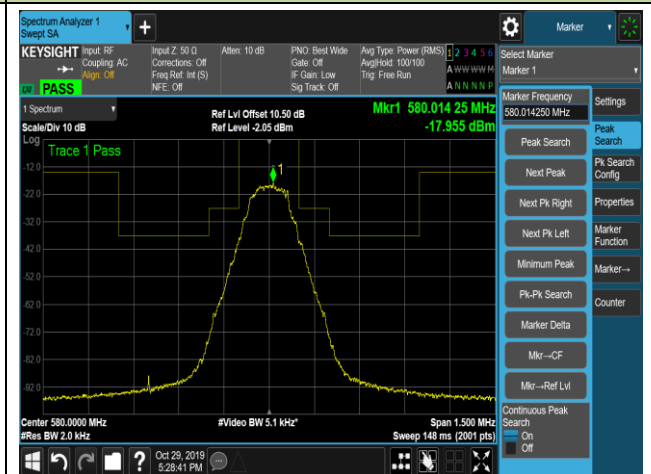


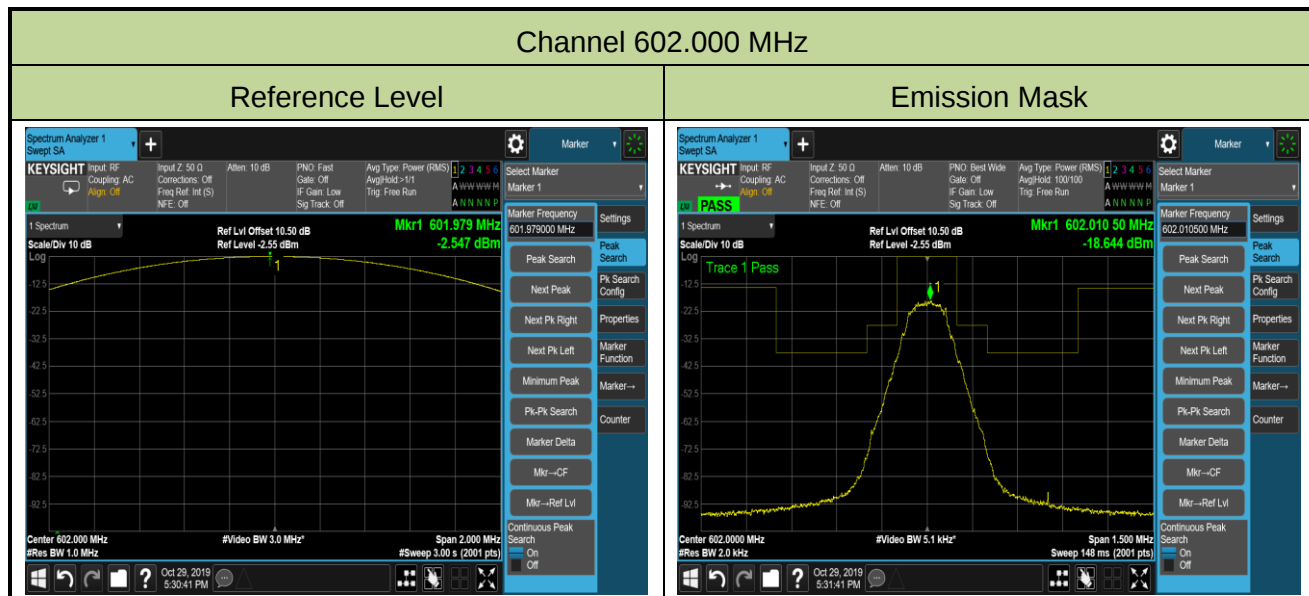
Channel 580.000 MHz

Reference Level



Emission Mask

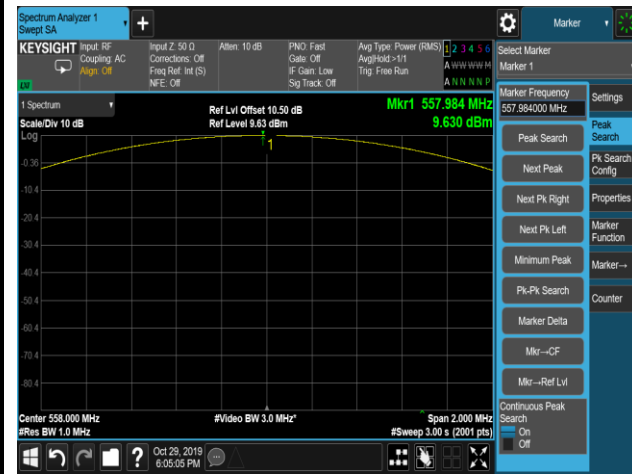




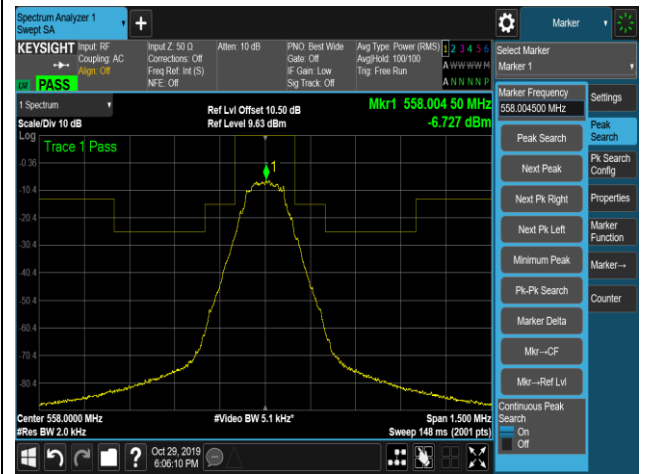
J52 Band 10mW - Emission Mask

Channel 558.000MHz

Reference Level

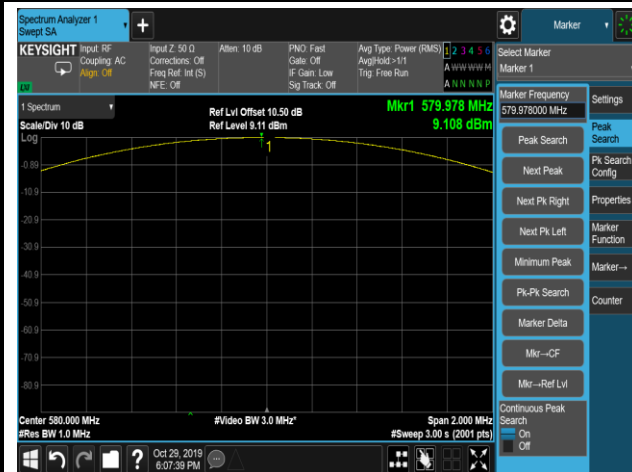


Emission Mask

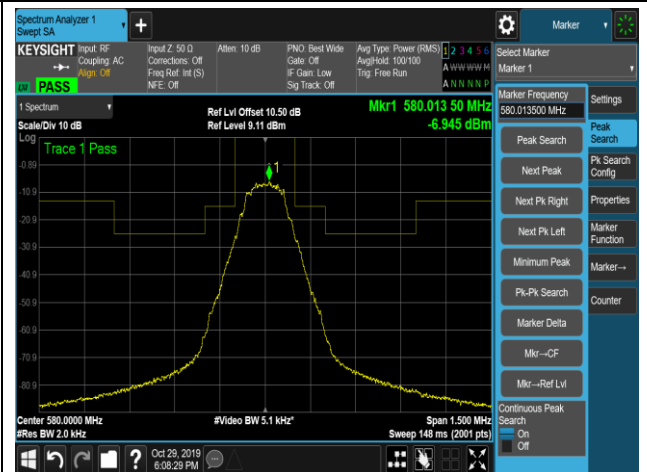


Channel 580.000 MHz

Reference Level



Emission Mask

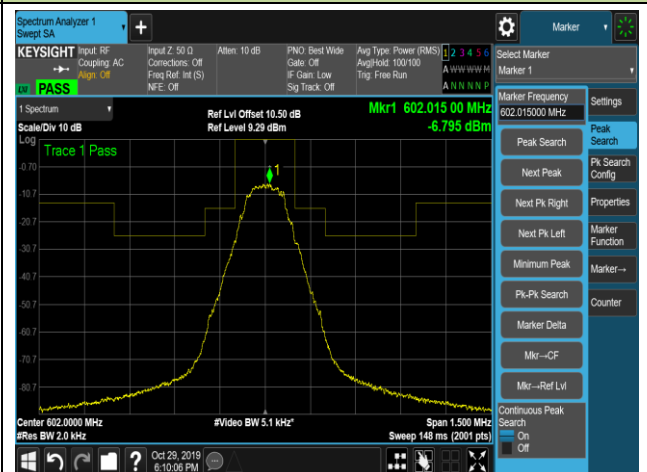


Channel 602.000 MHz

Reference Level



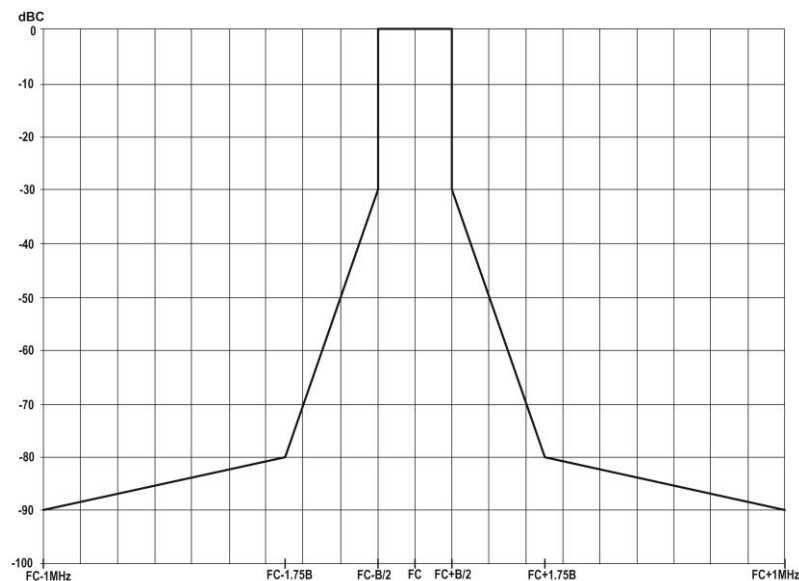
Emission Mask



6.4. Necessary Bandwidth Measurement

6.4.1. Test Limit

Digital emissions within the band from one megahertz below to one megahertz above the carrier frequency shall comply with the emission mask in section 8.3.2.2 of the European Telecommunications Institute Standard ETSI EN 300 422-1 v1.4.2, the transmitter output spectrum shall be within the mask defined as below figure.



6.4.2. Test Procedure Used

EN 300 422-1 V1.4.2 clause 8.3.2.1.

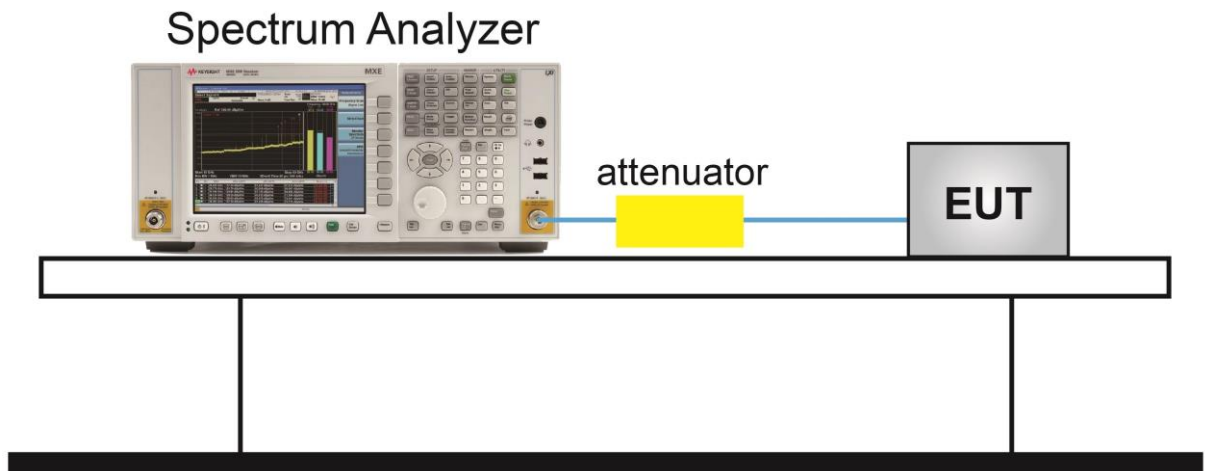
6.4.3. Test Setting

The EUT was powered up and the transmit frequency & power output of the EUT were selected.

The spectrum analyzer center frequency is set to the nominal EUT channel center frequency.

Only lowest and highest channel is required, at an output power level of 1mW and 10mW.

6.4.4. Test Setup



6.4.5. Test Result

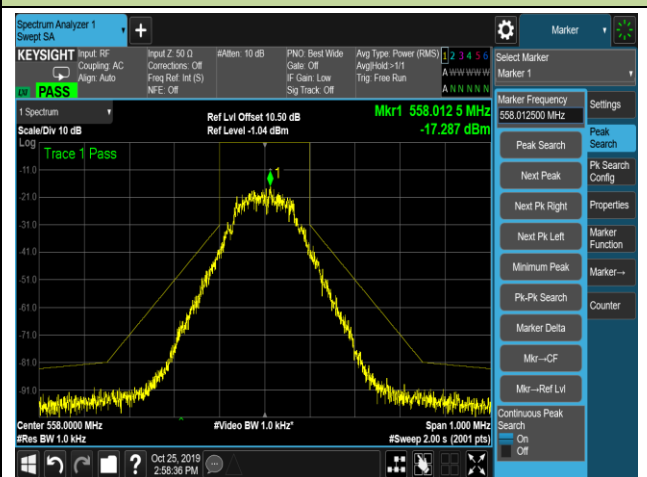
Test Site	TR3	Temperature	25°C
Test Engineer	Andy Zhu	Relative Humidity	52%
Test Mode	J52 Band	Test Date	2019/10/25

Necessary Bandwidth - 1mW, 558.000MHz

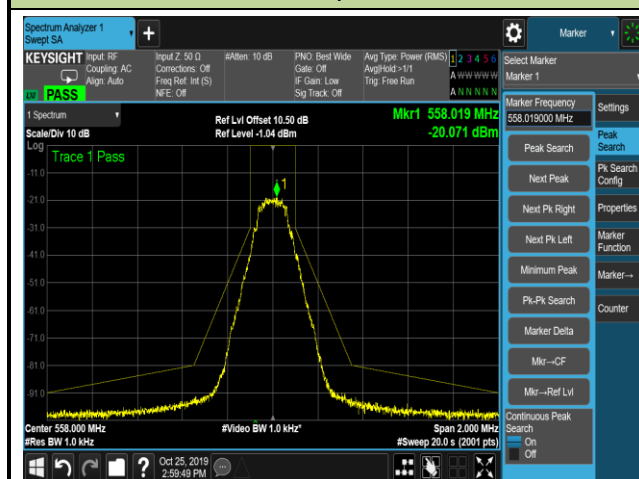
Step 1



Step 2



Step 3

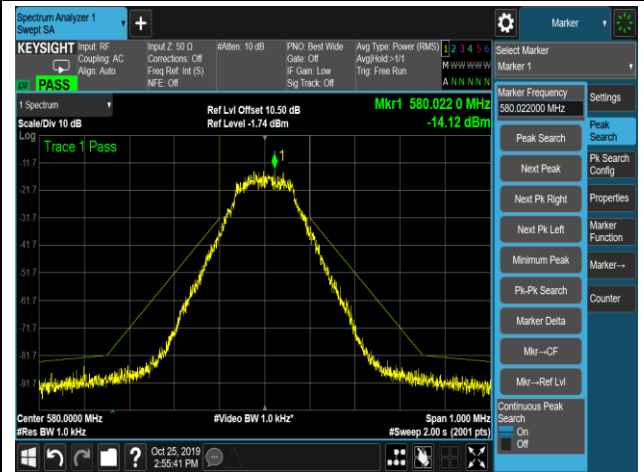


Necessary Bandwidth - 1mW, 580.000MHz

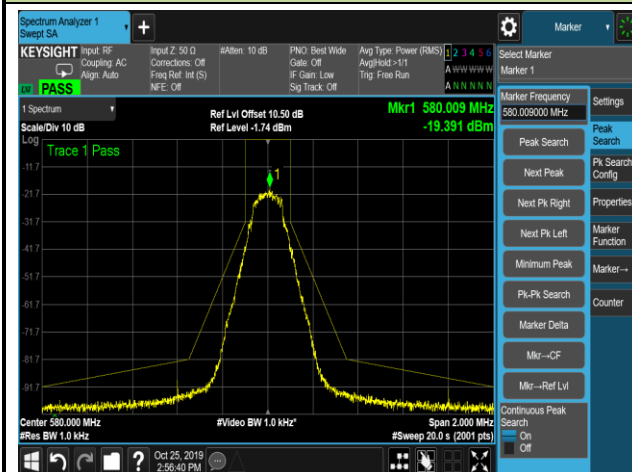
Step 1



Step 2



Step 3

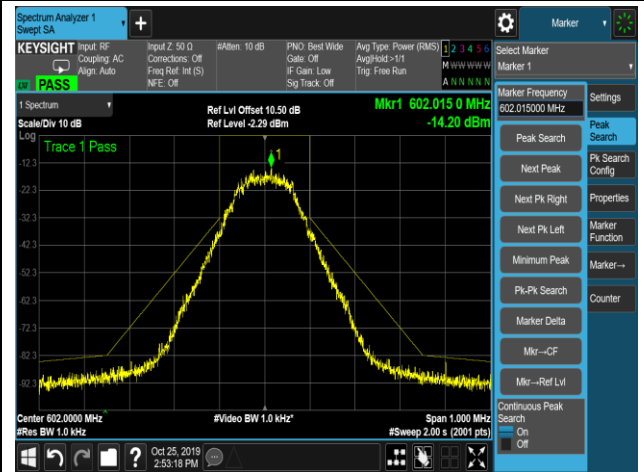


Necessary Bandwidth - 1mW, 602.000MHz

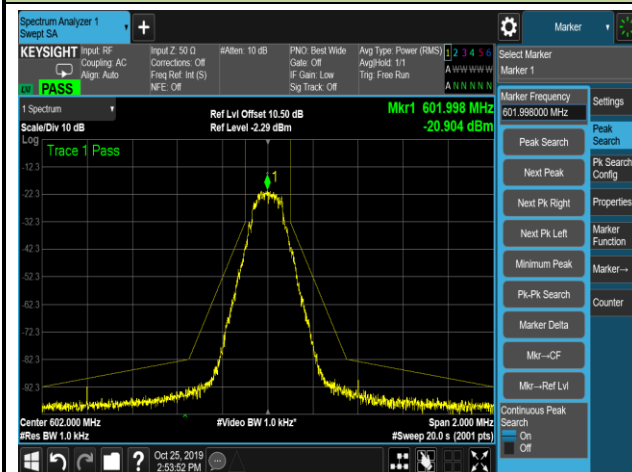
Step 1



Step 2



Step 3

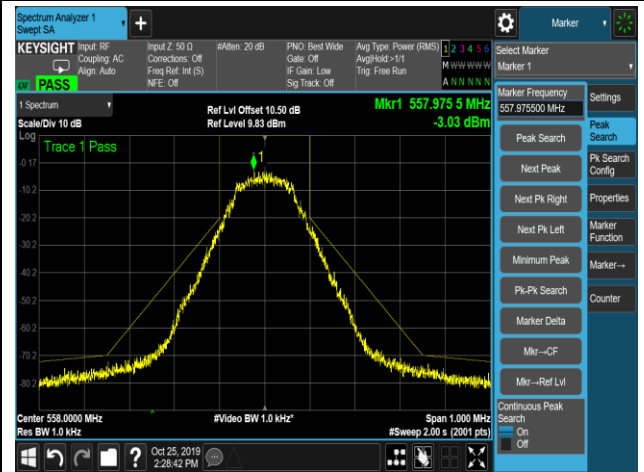


Necessary Bandwidth - 10mW, 558.000MHz

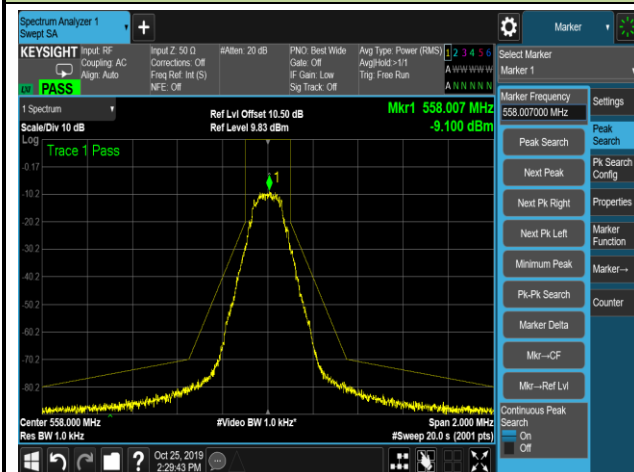
Step 1



Step 2



Step 3

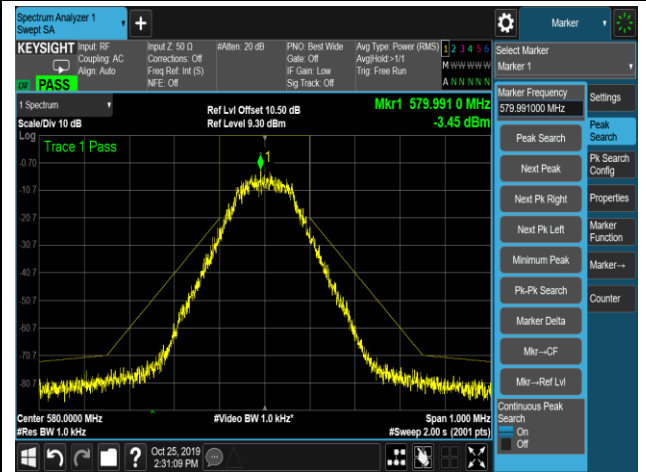


Necessary Bandwidth - 10mW, 580.000MHz

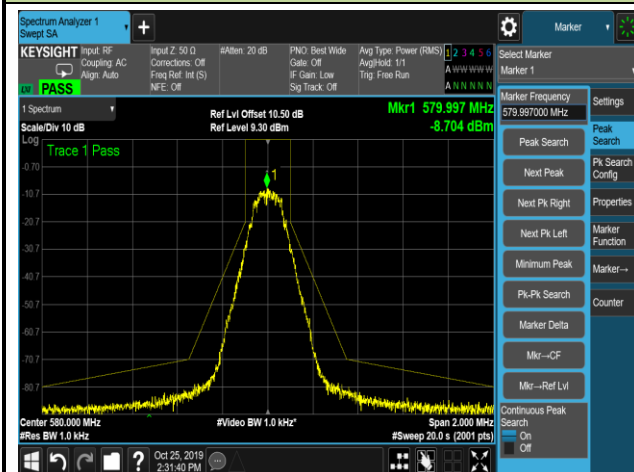
Step 1



Step 2



Step 3

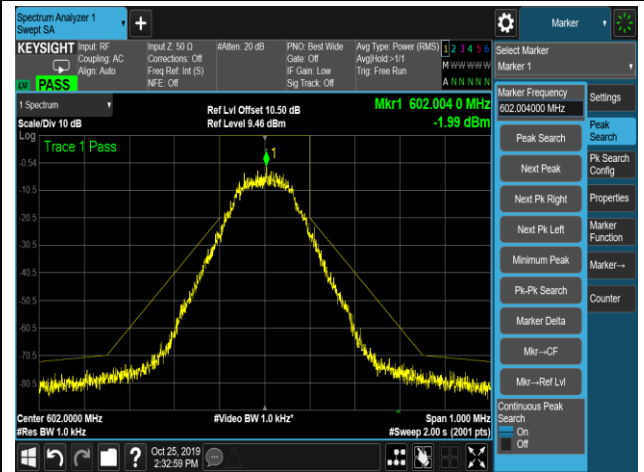


Necessary Bandwidth - 10mW, 602.000MHz

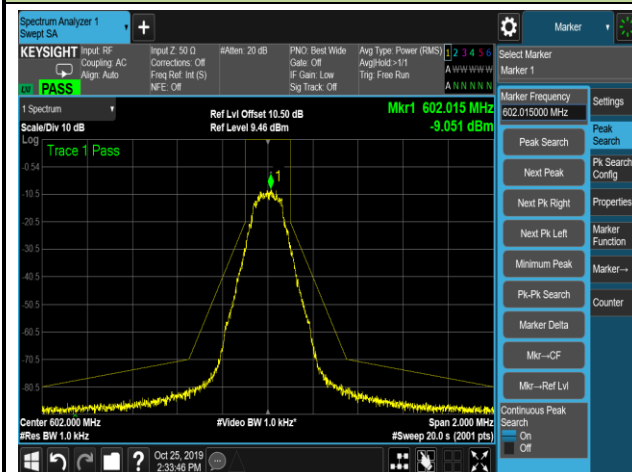
Step 1



Step 2



Step 3



6.5. Radiated Spurious Emissions Measurement

6.5.1. Test Limit

According to FCC Part 74.861(e)(7), beyond one megahertz below and above the carrier frequency, emissions shall comply with the limits specified in section 8.4 of ETSI EN 300 422-1 v1.4.2.

State	Frequency Range		
	47MHz to 74MHz, 87.5MHz to 137MHz 174MHz to 230MHz, 470MHz to 862MHz	Other Frequencies below 1000MHz	Frequencies above 1000MHz
Operation	4nW	250nW	1uW
Standby	2nW	2nW	20nW

6.5.2. Test Procedure Used

ETSI EN 300 422-1 V1.4.2 clause 8.4.2.

6.5.3. Test Setting

Table 1 - RBW as a function of frequency

Frequency	RBW
25 ~ 30 MHz	9 kHz
30 ~ 1000 MHz	100 kHz
1000 ~ 6000 MHz	1 MHz

Emissions shall be investigated up to the 10th harmonic of the fundamental.

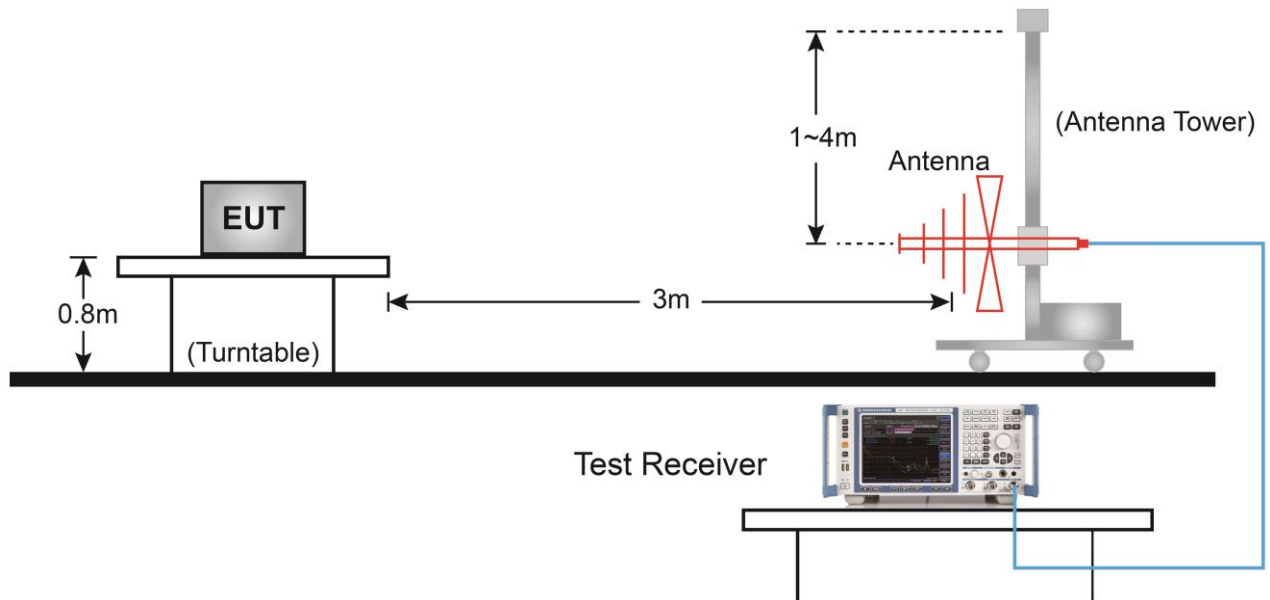
Compliance with the emission limits shall be demonstrated using a RMS Average detector.

All significant broadband and narrowband signals found in the preliminary sweeps were measured using a peak detector at a test distance of 3 meters.

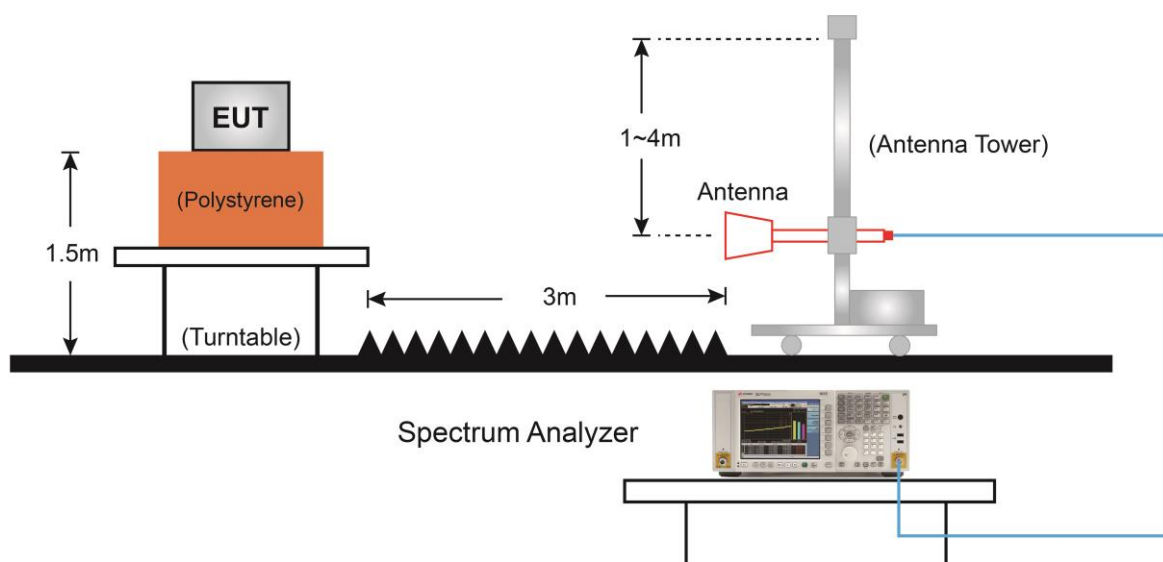
At each frequency at which a component is detected, the sample shall be rotated to obtain maximum response and the effective radiated power of that component determined by a substitution measurement.

6.5.4. Test Setup

Below 1GHz Test Setup:



Above 1GHz Test Setup:



6.5.5.Test Result

Test Site	TR3	Temperature	25°C
Test Engineer	Lewis Huang	Relative Humidity	54%
Test Mode	J52 Band - 1mW	Test Date	2019/11/10

Test Channel (MHz)	Frequency (MHz)	Ant. Pol. (H/V)	SG Reading (dBm)	Cable Loss (dB)	Substitute Antenna Gain (dBi)	EIRP (dBm)	Limit (dBm)	Margin (dB)
558.000	3348.00	H	-63.19	4.52	12.87	-54.84	-30.00	-24.84
	3906.00	H	-61.40	4.85	12.67	-53.58	-30.00	-23.58
	4465.00	H	-57.37	5.19	12.68	-49.88	-30.00	-19.88
	2232.00	V	-61.26	3.71	9.37	-55.60	-30.00	-25.60
	2790.00	V	-62.37	4.12	11.23	-55.26	-30.00	-25.26
	4465.00	V	-58.57	5.19	12.68	-51.08	-30.00	-21.08
580.000	2320.00	H	-62.26	3.77	9.76	-56.27	-30.00	-26.27
	2900.00	H	-62.02	4.19	11.45	-54.76	-30.00	-24.76
	4639.00	H	-56.60	5.35	12.62	-49.33	-30.00	-19.33
	2656.00	V	-57.84	4.03	10.88	-50.99	-30.00	-20.99
	4640.00	V	-58.95	5.35	12.62	-51.68	-30.00	-21.68
	5800.00	V	-60.55	5.35	13.09	-52.81	-30.00	-22.81
602.000	2408.00	H	-63.78	3.84	10.23	-57.39	-30.00	-27.39
	3010.00	H	-63.08	4.27	11.53	-55.82	-30.00	-25.82
	3612.00	H	-61.89	4.71	12.58	-54.02	-30.00	-24.02
	2131.00	V	-58.07	3.60	9.44	-52.23	-30.00	-22.23
	4214.00	V	-61.78	5.09	12.70	-54.17	-30.00	-24.17
	4816.00	V	-59.66	5.47	12.59	-52.54	-30.00	-22.54

Note 1: EIRP (dBm) = SG Reading (dBm) - Cable Loss (dB) + Substitute Antenna Gain (dBi)

Note 2: Margin (dB) = EIRP (dBm) - Limit (dBm)

Note 3: All data in this table is based on peak detection. Due to peak detection will yield amplitudes equal to or greater than amplitudes measured with the RMS detector. Thus, the data measured using the peak detector of a spectrum analyzer or EMI receiver will represent the worst-case results.

Test Site	TR3	Temperature	25°C
Test Engineer	Lewis Huang	Relative Humidity	54%
Test Mode	J52 Band - 10mW	Test Date	2019/11/10

Test Channel (MHz)	Frequency (MHz)	Ant. Pol. (H/V)	SG Reading (dBm)	Cable Loss (dB)	Substitute Antenna Gain (dBi)	EIRP (dBm)	Limit (dBm)	Margin (dB)
558.000	4465.00	H	-55.50	5.19	12.68	-48.01	-30.00	-18.01
	5022.00	H	-58.53	5.54	12.67	-51.40	-30.00	-21.40
	5580.00	H	-59.39	5.85	13.15	-52.09	-30.00	-22.09
	2232.00	V	-60.46	3.71	9.37	-54.80	-30.00	-24.80
	3906.00	V	-61.81	4.85	12.67	-53.99	-30.00	-23.99
	4465.00	V	-56.62	5.19	12.68	-49.13	-30.00	-19.13
580.000	2900.00	H	-62.77	4.19	11.45	-55.51	-30.00	-25.51
	3480.00	H	-62.55	4.58	12.68	-54.45	-30.00	-24.45
	4640.00	H	-59.99	5.35	12.62	-52.72	-30.00	-22.72
	2900.00	V	-63.13	4.19	11.45	-55.87	-30.00	-25.87
	3480.00	V	-63.09	4.58	12.68	-54.99	-30.00	-24.99
	5220.00	V	-60.14	5.61	12.89	-52.86	-30.00	-22.86
602.000	1195.00	H	-58.58	2.74	7.42	-53.90	-30.00	-23.90
	3612.00	H	-60.83	4.71	12.58	-52.96	-30.00	-22.96
	4816.00	H	-57.59	5.47	12.59	-50.47	-30.00	-20.47
	3612.00	V	-62.21	4.71	12.58	-54.34	-30.00	-24.34
	4816.00	V	-58.39	5.47	12.59	-51.27	-30.00	-21.27
	6020.00	V	-58.17	6.06	12.98	-51.25	-30.00	-21.25

Note 1: EIRP (dBm) = SG Reading (dBm) - Cable Loss (dB) + Substitute Antenna Gain (dBi)

Note 2: Margin (dB) = EIRP (dBm) - Limit (dBm)

Note 3: All data in this table is based on peak detection. Due to peak detection will yield amplitudes equal to or greater than amplitudes measured with the RMS detector. Thus, the data measured using the peak detector of a spectrum analyzer or EMI receiver will represent the worst-case results.

7. CONCLUSION

The data collected relate only the item(s) tested and show that the unit compliance with all the requirements of Parts 74H of the FCC Rules.

The End

Appendix A – Test Setup Photograph

Refer to “1910RSU040-UT” file.

Appendix B – EUT Photograph

Refer to “1910RSU040-UE” file.